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T-Type NPC Power Module

1200 V, 55 A IGBT, 600 V, 50 A IGBT

The NXH80T120L2Q0S1G is a power module containing a T-type neutral point clamped (NPC) three level inverter consisting of two 55 A/1200 V half-bridge IGBTs with 40 A/1200 V half-bridge diodes and two 50 A/600 V NP IGBTs with two 50 A/600 V NP diodes. The module also contains an on-board thermistor.

Features

- T-type NPC Module with 55 A/1200 V and 50 A/600 V IGBTs
- HB IGBT Specifications: $V_{CE(SAT)} = 2.5 \text{ V}$, $E_{SW} = 1000 \mu J$
- NP IGBT Specifications: $V_{CE(SAT)} = 1.5 \text{ V}$, $E_{SW} = 880 \mu J$
- Solder Pins
- Thermistor

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

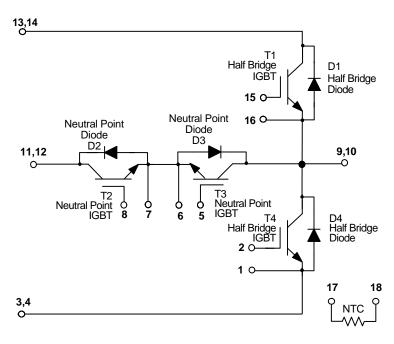
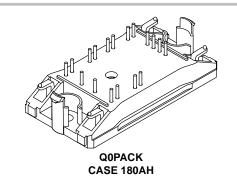


Figure 1. NXH80T120L2Q0S1G Schematic Diagram

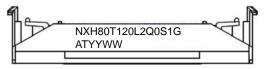


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MARKING DIAGRAM

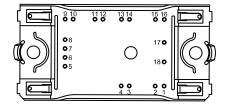


NXH80T120L2Q0S1G = Device Code YYWW = Year and Work Week Code A = Assembly Site Code

T = Test Site Code

G = Pb-Free Package

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information in the dimensions section on page 11 of this data sheet.

Table 1. ABSOLUTE MAXIMUM RATINGS (Note 1) $T_J = 25^{\circ}C$ unless otherwise noted

Rating	Symbol	Value	Unit
HALF BRIDGE IGBT			
Collector–Emitter Voltage	V _{CES}	1200	V
Gate-Emitter Voltage	V _{GE}	±20	V
Continuous Collector Current @ T _h = 80°C (T _J = 175°C)	I _C	57	А
Pulsed Collector Current (T _J = 175°C)	I _{Cpulse}	171	А
Maximum Power Dissipation @ T _h = 80°C (T _J = 175°C)	P _{tot}	125	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 600 V, $T_{J} \le 150^{\circ}C$	T _{sc}	5	μs
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
NEUTRAL POINT IGBT			
Collector–Emitter Voltage	V _{CES}	600	V
Gate-Emitter Voltage	V _{GE}	±20	V
Continuous Collector Current @ T _h = 80°C (T _J = 175°C)	I _C	52	А
Pulsed Collector Current (T _J = 175°C)	I _{Cpulse}	156	А
Maximum Power Dissipation @ T _h = 80°C (T _J = 175°C)	P _{tot}	95	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 400 V, $T_{J} \le 150^{\circ}C$	T _{sc}	5	μs
Minimum Operating Junction Temperature	T_{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
HALF BRIDGE DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Continuous Forward Current @ T _h = 80°C (T _J = 175°C)	I _F	25	А
Repetitive Peak Forward Current (T _J = 175°C, t _p limited by T _{Jmax})	I _{FRM}	70	А
Maximum Power Dissipation @ T _h = 80°C (T _J = 175°C)	P _{tot}	54	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
NEUTRAL POINT DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	600	V
Continuous Forward Current @ T _h = 80°C.(T _J = 175°C)	I _F	31	А
Repetitive Peak Forward Current (T _J = 175°C, t _p limited by T _{Jmax})	I _{FRM}	85	А
Maximum Power Dissipation @ T _h = 80°C (T _J = 175°C)	P _{tot}	53	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
THERMAL PROPERTIES			
Storage Temperature range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60 Hz	V _{is}	3000	V_{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 2. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	(T _{Jmax} -25)	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

^{1.} Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 3. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
HALF BRIDGE IGBT CHARACTERISTICS		•				
Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1200 V	I _{CES}	_	_	300	μΑ
Collector–Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 80 A, T _J = 25°C	V _{CE(sat)}	_	2.50	2.85	V
	V _{GE} = 15 V, I _C = 80 A, T _J = 150°C	1 I	_	2.15	-	1
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1.5 \text{ mA}$	V _{GE(TH)}	-	5.45	6.4	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	_	300	nA
Turn-on Delay Time		t _{d(on)}	-	37	-	ns
Rise Time	1	t _r	-	23	_	1
Turn-off Delay Time	T _J = 25°C	t _{d(off)}	-	190	-	1
Fall Time	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 4 \Omega$	t _f	-	30	-	1
Turn-on Switching Loss per Pulse	VGE = ±10 V, NG = 122	Eon	-	320	-	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	-	680	-	1
Turn-on Delay Time		t _{d(on)}	-	30	-	ns
Rise Time	1	t _r	-	25	_	1
Turn-off Delay Time	$T_J = 125^{\circ}C$	t _{d(off)}	-	230	-	1
Fall Time	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 4 \Omega$	t _f	-	90	-	1
Turn-on Switching Loss per Pulse		E _{on}	-	500	_	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	_	1300	-	1
Input Capacitance		C _{ies}	-	19400	-	pF
Output Capacitance	V _{CE} = 25 V, V _{GE} = 0 V, f = 10 kHz	C _{oes}	-	400	-	1
Reverse Transfer Capacitance	1	C _{res}	_	340	-	1
Total Gate Charge	$V_{CE} = 600 \text{ V}, I_{C} = 80 \text{ A}, V_{GE} = 15 \text{ V}$	Qg	-	800	-	nC
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 100 μ m, λ = 0.84 W/mK	R _{thJH}	-	0.76	-	°C/W
NEUTRAL POINT DIODE CHARACTERIST	rics					
Diode Forward Voltage	I _F = 50 A, T _J = 25°C	V _F	_	2.60	2.85	V
	I _F = 50 A, T _J = 150°C	1 I	-	2.0	-	1
Reverse Recovery Time		t _{rr}	_	30	_	ns
Reverse Recovery Charge	T _J = 25°C	Q_{rr}	-	305	-	μС
Peak Reverse Recovery Current	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$	I _{RRM}	_	22	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	di/dt	_	1870	_	A/μs
Reverse Recovery Energy	1	E _{rr}	-	77	-	μJ
Reverse Recovery Time		t _{rr}	_	34	_	ns
Reverse Recovery Charge	Tj = 125°C	Q_{rr}	_	910	_	nC
Peak Reverse Recovery Current	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$	I _{RRM}	_	50	-	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	di/dt	-	4200	-	A/μs
Reverse Recovery Energy	1	E _{rr}	_	200	-	μJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 100 μ m, λ = 0.84 W/mK	R _{thJH}	-	1.80	_	°C/W
NEUTRAL POINT IGBT CHARACTERISTIC	cs	L		-		-
Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 600 V	I _{CES}	-	_	200	μΑ
Collector–Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 50 A, T _J = 25°C	V _{CE(sat)}	_	1.50	1.75	V
_	V _{GE} = 15 V, I _C = 50 A, T _J = 150°C	(_	1.60	_	1
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.2 \text{ mA}$	V _{GE(TH)}	_	5.45	6.4	V
Gate Leakage Current	$V_{GE} = 20 \text{ V}, V_{CE} = 0 \text{ V}$	I _{GES}	_	_	200	nA

Table 3. ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
NEUTRAL POINT IGBT CHARACTERISTIC	cs					
Turn-on Delay Time		t _{d(on)}	-	23	_	ns
Rise Time	7	t _r	-	17	_	
Turn-off Delay Time	$T_{\rm J} = 25^{\circ}{\rm C}$	t _{d(off)}	-	108	_	
Fall Time	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 4 \Omega$	t _f	-	31	_	
Turn-on Switching Loss per Pulse		E _{on}	-	360	_	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	-	520	_	
Turn-on Delay Time		t _{d(on)}	-	27	_	ns
Rise Time	1	t _r	-	17	_	
Turn-off Delay Time	T _J = 125°C	t _{d(off)}	_	130	_	
Fall Time	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 4 \Omega$	t _f	-	75	_	
Turn-on Switching Loss per Pulse	- GE = 10 1, 1.1g 1 = 1	E _{on}	-	535	_	μJ
Turn-off Switching Loss per Pulse	7	E _{off}	-	865	_	
Input Capacitance		C _{ies}	_	9400	_	pF
Output Capacitance	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 10 \text{ kHz}$	C _{oes}	_	280	_	
Reverse Transfer Capacitance	7	C _{res}	_	250	_	
Total Gate Charge	V _{CE} = 480 V, I _C = 50 A, V _{GE} = 15 V	Qg	_	395	_	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness < 100 μ m, λ = 0.84 W/mK	R _{thJH}	-	1.00	_	°C/W
HALF BRIDGE DIODE CHARACTERISTIC	s					
Diode Forward Voltage	I _F = 40 A, T _J = 25°C	V _F	-	2.65	3.45	V
	I _F = 40 A, T _J = 150°C		_	2.15	_	
Reverse Recovery Time		t _{rr}	_	38	_	ns
Reverse Recovery Charge	T _{.1} = 25°C	Q _{rr}	_	853	_	nC
Peak Reverse Recovery Current	$V_{CE} = 350 \text{ V, } I_{C} = 40 \text{ A}$	I _{RRM}	_	43	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	di/dt	_	2600	_	A/μs
Reverse Recovery Energy	7	E _{rr}	_	200	_	μJ
Reverse Recovery Time		t _{rr}	-	300	_	ns
Reverse Recovery Charge	T _{.1} = 125°C	Q _{rr}	-	2550	_	nC
Peak Reverse Recovery Current	$V_{CE} = 350 \text{ V}, I_{C} = 40 \text{ A}$	I _{RRM}	_	57	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_G = 4 \Omega$	di/dt	-	2340	_	A/μs
Reverse Recovery Energy	7	E _{rr}	_	390	_	μJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness < 100 μ m, λ = 0.84 W/mK	R _{thJH}	-	1.76	-	°C/W
THERMISTOR CHARACTERISTICS						
Nominal resistance		R ₂₅	-	22	_	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	-	1486	_	Ω
Deviation of R25		ΔR/R	- 5		5	%
Power dissipation		P _D	-	200	-	mW
Power dissipation constant			-	2	-	mW/K
B-value	B(25/50), tolerance ±3%		-	3950	-	K
B-value	B(25/100), tolerance ±3%		_	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS - Half Bridge IGBT and Neutral Point Diode

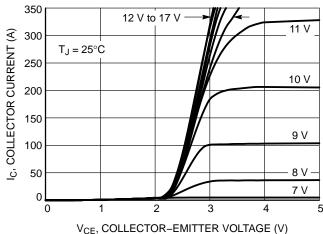


Figure 1. IGBT Typical Output Characteristics

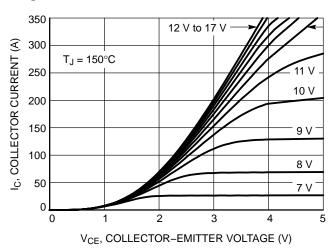


Figure 2. IGBT Typical Output Characteristics

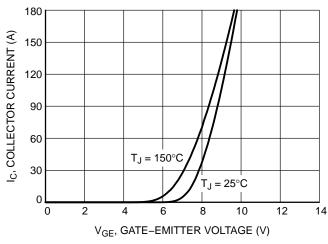


Figure 3. IGBT Typical Transfer Characteristics

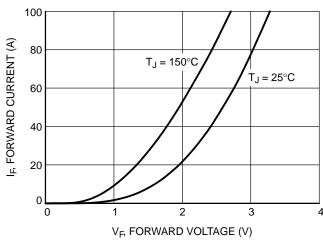


Figure 4. Diode Forward Characteristics

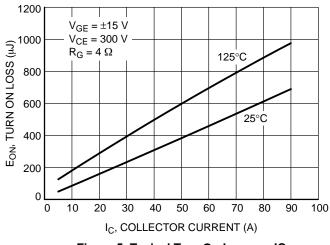


Figure 5. Typical Turn On Loss vs. IC

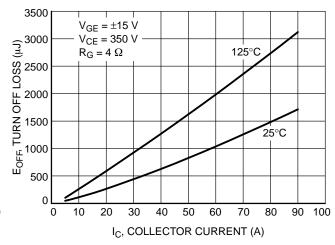
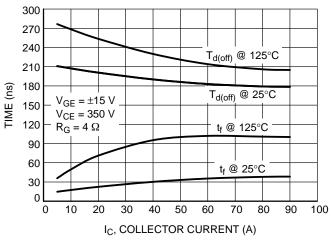


Figure 6. Typical Turn Off Loss vs. IC

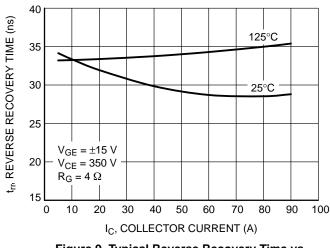
TYPICAL CHARACTERISTICS - Half Bridge IGBT and Neutral Point Diode



80 $V_{GE} = \pm 15 \text{ V}$ 70 $V_{CE} = 350 \text{ V}$ $R_G = 4 \Omega$ 60 50 T_{d(on)} @ 25°C 40 T_{d(on)} @ 125°C 30 @ 125°C 20 t_r @ 25°C 10 0 80 90 100 0 10 20 30 40 50 60 70 IC, COLLECTOR CURRENT (A)

Figure 7. Typical Switching Times vs. IC

Figure 8. Typical Switching Times vs. IC



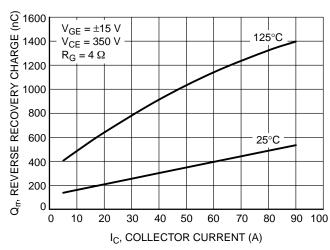
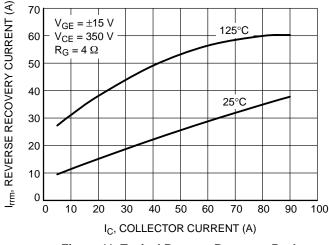


Figure 9. Typical Reverse Recovery Time vs.

Figure 10. Typical Reverse Recovery Charge vs. IC



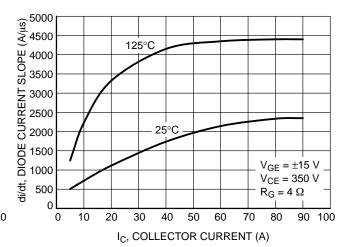


Figure 11. Typical Reverse Recovery Peak
Current vs. IC

Figure 12. Typical Diode Current Slope vs. IC

TYPICAL CHARACTERISTICS - Half Bridge IGBT and Neutral Point Diode

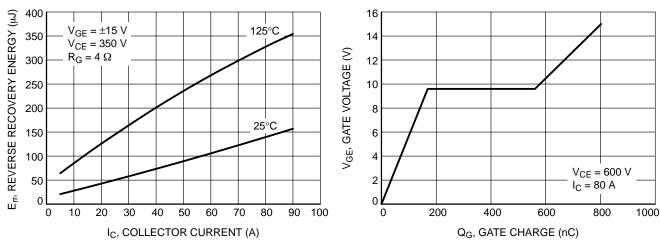


Figure 13. Typical Reverse Recovery Time vs. IC

Figure 14. Gate Voltage vs. Gate Charge

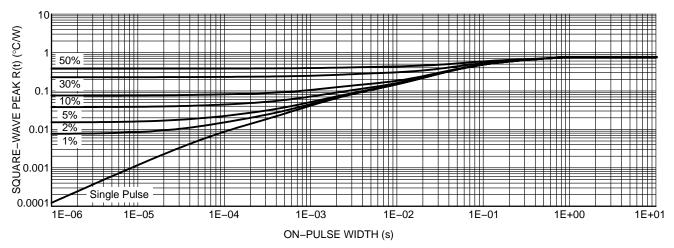


Figure 15. IGBT Transient Thermal Impedance

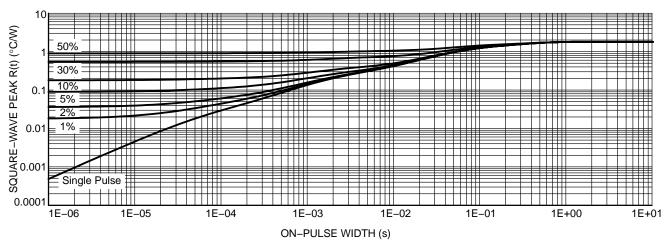


Figure 16. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

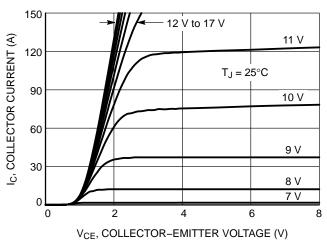


Figure 17. IGBT Typical Output Characteristics

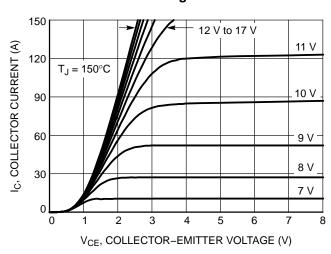


Figure 18. IGBT Typical Output Characteristics

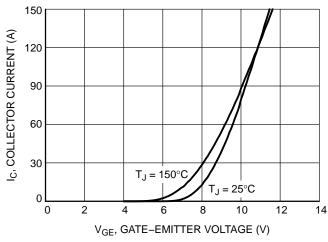


Figure 19. IGBT Typical Transfer Characteristics

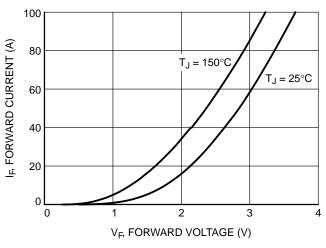


Figure 20. Diode Forward Characteristic

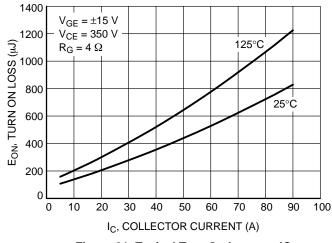


Figure 21. Typical Turn On Loss vs. IC

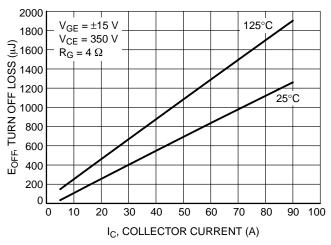


Figure 22. Typical Turn Off Loss vs. IC

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

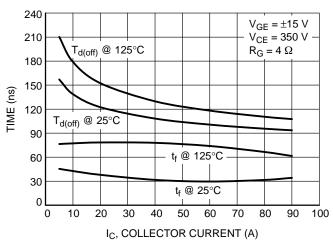


Figure 23. Typical Switching Times vs. IC

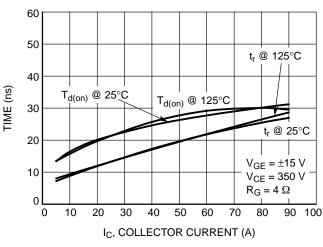


Figure 24. Typical Switching Times vs. IC

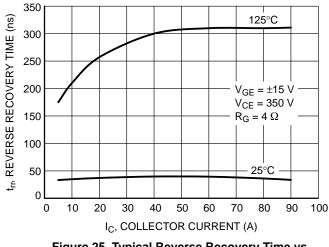


Figure 25. Typical Reverse Recovery Time vs.

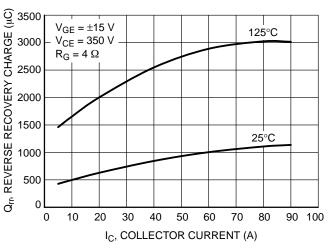


Figure 26. Typical Reverse Recovery Charge vs. IC

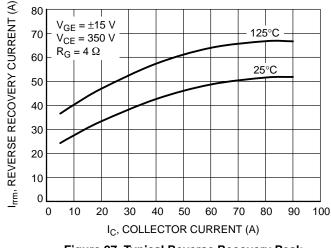


Figure 27. Typical Reverse Recovery Peak Current vs. IC

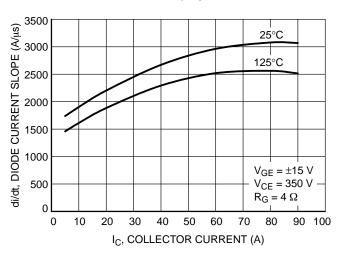


Figure 28. Typical Diode Current Slope vs. IC

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

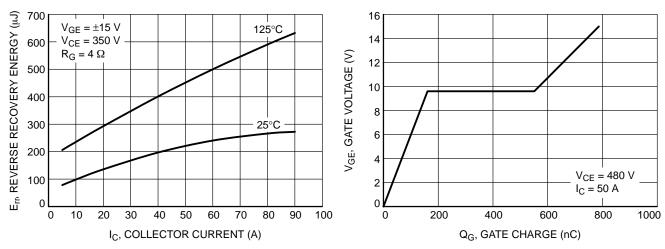


Figure 29. Typical Reverse Recovery Energy vs. IC

Figure 30. Gate Voltage vs. Gate Charge

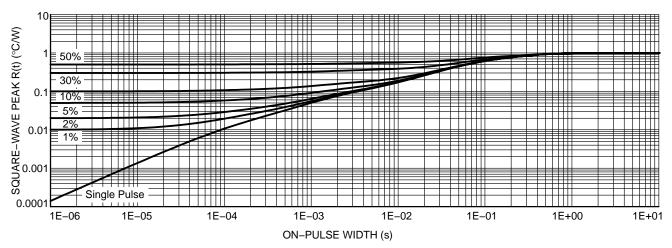


Figure 31. IGBT Transient Thermal Impedance

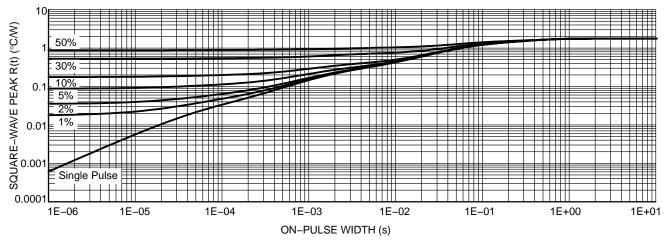


Figure 32. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS – Thermistor

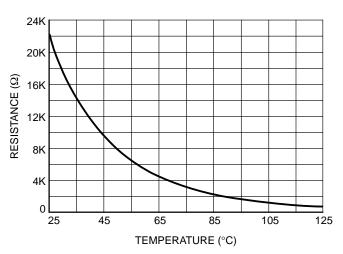


Figure 33. Thermistor Characteristics

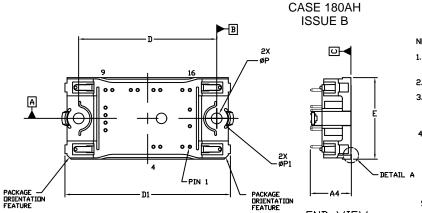
ORDERING INFORMATION

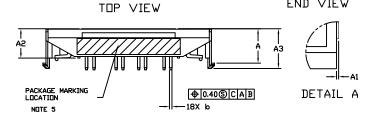
Orderable Part Number	Marking	Package	Shipping
NXH80T120L2Q0S1G Q0PACK	NXH80T120L2Q0S1G	Q0PACK – Case 180AH (Pb–Free and Halide–Free)	24 Units / Blister Tray

PACKAGE DIMENSIONS

PIM18, 55x32.5 / Q0PACK

END VIEW





SIDE VIEW

MOUNTING HOLE POSITION

NOTE 4

	PIN PE	NOITIZE		PIN PI	PIN POSITION		PIN POSITION			PIN P	NDITIZE
PIN	х	Υ	PIN	Х	Υ	PIN	Х	Y	PIN	Х	Υ
1	16.80	11.30	10	-14.10	-10.70	1	16.80	-11.30	10	-14.10	10.70
2	13.80	11.30	11	-6.70	-10.70	2	13.80	-11.30	11	-6.70	10.70
3	5.00	11.30	12	-4.00	-10.70	3	5.00	-11.30	12	-4.00	10.70
4	2.30	11.30	13	2.30	-10.70	4	2.30	-11.30	13	2.30	10.70
5	-16.80	4.70	14	5.00	-10.70	5	-16.80	-4.70	14	5.00	10.70
6	-16.80	1.70	15	13.80	-10.70	6	-16.80	-1.70	15	13.80	10.70
7	-16.80	-1.30	16	16.80	-10.70	7	-16.80	1.30	16	16.80	10.70
8	-16.80	-4.30	17	16.80	-3.50	8	-16.80	4.30	17	16.80	3.50
9	-16.80	-10.70	18	16.80	3.10	9	-16.80	10.70	18	16.80	-3.10

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

	MILLIMETERS					
DIM	MIN.	N□M.				
Α	13.50	13.90				
A1	0.10	0.30				
A2	11.50	11.90				
A3	15.65	16.05				
A4	16.35 REF					
b	0.95	1.05				
D	54.80	55.20				
D1	65.60	66.20				
Ε	32.20	32.80				
Р	4.20	4.40				
P1	8.90	9.10				

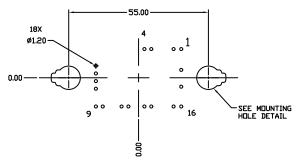
PACKAGE DIMENSIONS

PIM18, 55x32.5 / Q0PACK

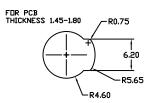
CASE 180AH ISSUE O

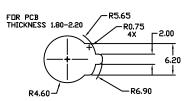
MOUNTING HOLE POSITION

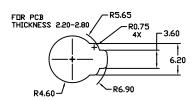
	PIN POSITION				PIN P	NOITIZE
PIN	х	Υ		PIN	х	Υ
1	16.80	11.30		10	-14.10	-10.70
2	13.80	11.30		11	-6.70	-10.70
3	5.00	11.30		12	-4.00	-10.70
4	2.30	11.30		13	2.30	-10.70
5	-16.80	4.70		14	5.00	-10.70
6	-16.80	1.70		15	13.80	-10.70
7	-16.80	-1.30		16	16.80	-10.70
8	-16.80	-4.30		17	16.80	-3.50
9	-16.80	-10.70		18	16.80	3.10
	<u> </u>					·



RECOMMENDED
MOUNTING PATTERN







MOUNTING HOLE DETAIL

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